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(12) **United States Design Patent**
Petersen

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(54) **MICROCHIP PROBE**

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(**) Term: **14 Years**

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D14/436, 437; 29/829; 174/250, 253, 255,
174/748, 752; 361/720, 760; 439/68; 324/716,
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See application file for complete search history.

(56) **References Cited**

U.S. PATENT DOCUMENTS

6,211,685 B1 * 4/2001 Stanford et al. 324/716
7,442,571 B2 * 10/2008 Park et al. 438/52
D602,885 S * 10/2009 Nielsen D13/182
2009/0085591 A1 * 4/2009 Soubh et al. 324/754

2009/0167334 A1 * 7/2009 Fjelstad et al. 324/754

* cited by examiner

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(57) **CLAIM**

The ornamental design for a microchip probe, as shown.

DESCRIPTION

FIG. 1 is a front elevational view of a microchip probe, in accordance with my new design;

FIG. 2 is a rear elevational view of the microchip probe of FIG. 1;

FIG. 3 is a left side elevational view of the microchip probe of FIG. 1;

FIG. 4 is a right side elevational view of the microchip probe of FIG. 1;

FIG. 5 is a top plan view of the microchip probe of FIG. 1;

FIG. 6 is a bottom plan view of the microchip probe of FIG. 1; and,

FIG. 7 is an enlarged, detailed, front elevational view of the microchip probe of FIG. 1, showing a portion of the front surface of the microchip probe.

1 Claim, 1 Drawing Sheet



